Applicants: Been-Yih Jin, et al. Attorney's Docket No.: 10559-587001 Serial No.: 10/081,992 Intel Docket No.: P12768

Serial No.: 10/081,992 Filed: February 21, 2002

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REMARKS

Claims 8 to 21 are pending in this application. Claims 8 and 19 are independent.

Favorable reconsideration and further examination are respectfully requested.

Claims 8 to 21 were rejected under 35 U.S.C. §103 over U.S. Patent No. 5,545,574

(Chen) in view of U.S. Patent No. 6,100,120 (Yu) and U.S. Patent No. 5,185,286 (Eguchi). As

shown above, Applicants have amended the claims to define the invention with greater clarity.

In view of these amendments, withdrawal of the art rejection is respectfully requested.

Both independent claim 8 and independent claim 19 have been amended to specify that a

gate dielectric layer comprises a material having a dielectric constant greater than 7.8, and that

the material comprises a compound having a free energy of formation that is lower than a free

energy of formation of a compound that is formed between the material and a semiconductor

substrate that is substantially free of silicon. As described on page 10 of the specification, one

advantage of this configuration is that an atomically smooth surface is formed between the

substrate and the material.

The applied art is not understood to disclose or to suggest the foregoing features of

claims 8 and 19. More specifically, Chen describes use of germanium as a substrate (see, e.g.,

column 2, line 57). Although Applicants do not concede that this mention of germanium means

that the substrate is "substantially free of silicon" as required by the claims, Applicants have

nevertheless amended the claims in an effort to advance prosecution.

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Yu describes use of a gate insulator with a high dielectric constant (see, e.g., column 4,

lines 29 and 30). Yu, however, does not disclose or suggest use of a such a gate insulator with a

substrate that is substantially free of silicon.

Accordingly, Yu, whether taken alone or in combination with Chen, could not possibly

disclose or suggest using a material for the gate insulator that is compatible with a substrate that

is substantially free of silicon, i.e., a compound having a free energy of formation that is lower

than a free energy of formation of a compound that is formed between the material and the

semiconductor substrate. Eguchi, which was cited for its alleged disclosure of contact formation,

is not understood to add anything that would remedy this deficiency of Chen and Yu.

For at least the foregoing reasons, claims 8 and 19 are believed to be patentable.

In view of the foregoing amendments and remarks, the entire application is now believed

to be in condition for allowance, and such action is respectfully requested at the Examiner's

earliest convenience.

Applicants' undersigned attorney can be reached at the address shown below.

No fees are believed to be due for this Amendment; however, if any fees are due, please

apply them to Deposit Account 06-1050.

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Respectfully submitted,

Reg. No.